## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Priority Application Serial No	
Priority Filing Date	August 16, 2001
Inventor	Charles H. Dennison
Assignee	Micron Technology, Inc.
Priority Group Art Unit	2825
Priority Examiner	R. Rocchegiani
Attorney's Docket No	MI22-2346
Title: Semiconductor Processing Methods, and Semicond	luctor Assemblies

## INFORMATION DISCLOSURE STATEMENT

References - - See attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

The listed references were cited by, or submitted to, the Office in the parent, copending application of the above-identified application. The above-identified application is a divisional application of co-pending application Serial No. 09/932,040, filed August 16, 2001, upon which the above-identified application relies for a priority date under 35 U.S.C. §120. Such prior disclosure is sufficient for the above-identified application as far as copies of the references are concerned. 37 C.F.R. §1.98(d) and MPEP §609(2).

Citation of these references is respectfully requested.

Respectfully submitted,

Date: 7-29-03

D. Brent Kenady Reg. No. 40,045

Sheet 1 of 1 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. M122-2346 SERIAL NO. Form PTO-1449 Filed Herewith APPLICANT LIST OF ART CITED BY APPLICANT Charles H. Dennison (Use several sheets if necessary) GROUP FILING DATE U.S. PATENT DOCUMENTS Class Subclass Filing Date Date Name Document \*Examiner If Appropriate Number Initial AΑ 5,742,555 04/98 Marr et al. Cutter et al. ΑB 6,154,398 11/00 AC 6,081,021 06/00 Gambino et al. 5,171,715 12/92 Husher et al. AD 5,110,754 05/92 Lowrey et al. ΑE ΑF 5,674,787 10/97 Zhao et al. Dixit et al. AG 5,233,217 08/93 10/02 Brintzinger et al. 6,458,631 B1 ΑH 6,124,194 09/00 Shao et al. ΑI 6,335,228 B1 01/02 Fuller et al. AJ ΑK 5,780,323 07/98 Forouhi et al. FOREIGN PATENT DOCUMENTS Class Subclass Translation Date Country Document Number Yes No ΑL ΑM ΑN ΑO ΑP OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AR

AS ΑT DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**EXAMINER**